



Product data sheet

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AO3407A HF Semiconductor Compiance

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Features

- -30V,-4.2A, RDS(ON) =45mΩ@VGS = 10V
- Fast switching
- Green Device Available

Applications

- Notebook
- Load Switch
- Battery Protection
- Hand held Instruments

BVDSS	RDSON	ID
-30V	45mΩ	-4.2A

Absolute Maximum Ratings Tc=25°C unless otherwise noted

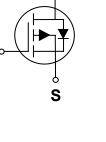
Symbol	Parameter	Rating	Units
Vds	Drain-Source Voltage	-30	V
Vgs	Gate-Source Voltage	±20	V
1-	Drain Current – Continuous (T _A =250)	-4.2	A
D	Drain Current – Continuous (T _A =700)	-3.3	A
Ідм	Drain Current – Pulsed ¹	- 16.4	А
D-	Power Dissipation (T _A =250)	1.56	W
Po	Power Dissipation – Derate above 250	0.012	W/ C
Тѕтс	Storage Temperature Range	-55 to 150	С
TJ	Operating Junction Temperature Range	-55 to 150	С

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		80	C/ W



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Semiconductor Compiance

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , I⊳=-250uA	-30			V
∆BV _{DSS} /∆TJ	BVDss Temperature Coefficient	Reference to 250 , ID=-1mA		-0.03		V/ C
1	Drain Source Leekege Current	VDS=-30V , VGS=0V , TJ=250			- 1	uA
IDSS	Drain-Source Leakage Current	VDS=-24V , VGS=0V , TJ=1250			- 10	uA
lgss	Gate-Source Leakage Current	$V_{GS=} \pm 20V$, $V_{DS}=0V$			±100	nA

On Characteristics

Basian		Vgs=-10V , Id=-3A		45	60	mΩ
Rds(ON)	Static Drain-Source On-Resistance	Vgs=-4.5V , Id=-2A		60	80	mΩ
VGS(th)	Gate Threshold Voltage		-1.0	- 1.5	-2.2	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	Vgs=Vds , Id =-250uA		4		mV/ C
gfs	Forward Transconductance	Vds=-10V , Id=-3A		3.5		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2,3}		 5.1	
Qgs	Gate-Source Charge ^{2,3}	V _{DS} =-15V , V _{GS} =-4.5V , I _D =-3A	 2	 nC
Qgd	Gate-Drain Charge ^{2,3}		 2.2	
Td(on)	Turn-On Delay Time ^{2,3}		 3.4	
Tr	Rise Time ^{2,3}	VDD=-15V , VGS=-10V , RG=6Ω	 10.8	
Td(off)	Turn-Off Delay Time ^{2,3}	ID=-1A	 26.9	 ns
Tf	Fall Time ^{2,3}		 6.9	
Ciss	Input Capacitance		 560	
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , F=1MHz	 55	 pF
Crss	Reverse Transfer Capacitance		 40	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current				-4.2	А
lsм	Pulsed Source Current	Vg=VD=0V , Force Current			- 16.4	А
Vsd	Diode Forward Voltage	Vgs=0V , Is=-1A , TJ=250			- 1.2	V

Note :

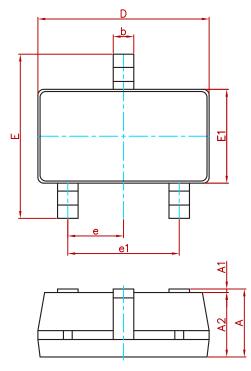
1. Repetitive Rating : Pulsed width limited by maximum junction temperature. 2. The data tested by pulsed , pulse width ≤ 300 us , duty cycle $\leq 2\%$.

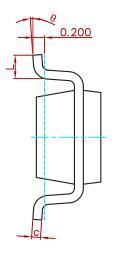
3. Essentially independent of operating temperature.





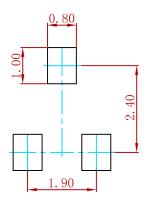
PACKAGE MECHANICAL DATA





Symbol	Dimensions In Millimeters		Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
A	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
С	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E1	1.500	1.700	0.059	0.067
E	2.650	2.950	0.104	0.116
е	0.950(0(BSC)		(BSC)
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°

Suggested Pad Layout



Note:

1.Controlling dimension:in millimeters.

2.General tolerance:± 0.05mm.3.The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
AO3407A	SOT-23-3L	3000





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